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Application/Control No.	Appl Reex
10/810,035	WEI
Examiner	Art L

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Applicant(s)/Patent under Reexamination
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Art Unit
2818

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Class	Subclass	Date	Examiner
257	298	8/14/2005	TŤN
257	315	8/14/2005	TTN
257	91	8/15/2005	TTN
257	98	8/15/2005	TTN
365	185.05	8/15/2005	TTN
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INT	INTERFERENCE SEARCHED		
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